

**FCC ID: 2ATAE-0W7**

Portable device

According to §15.247(e)(i) and §1.1307(b)(1), systems operating under the provisions of this section shall be operated in a manner that ensures that the public is not exposed to radio frequency energy level in excess of the Commission's guidelines.

According to KDB447498 D01 General RF Exposure Guidance V06

The 1-g SAR and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances  $\leq$  50 mm are determined by:

$[(\text{max. power of channel, including tune-up tolerance, mW}) / (\text{min. test separation distance, mm})] \cdot [\sqrt{f(\text{GHz})}] \leq 3.0 \text{ for 1-g SAR and } \leq 7.5 \text{ for 10-g extremity SAR, where:}$

- $f(\text{GHz})$  is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison

When the minimum test separation distance is  $<$  5 mm, a distance of 5 mm is applied to determine SAR test exclusion.

BR+EDR:

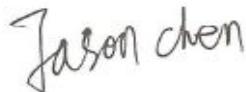
Antenna Type: PCB Antenna

Antenna Gain: 0dBi

Modulation	Channel Freq. (GHz)	Conducted power (dBm)	Conducted power (mW)	Tune-up power (dBm)	Max tune-up power (dBm)	Max tune-up power (mW)	Distance (mm)	Result calculation	1g SAR Exclusion threshold	SAR test exclusion
GFSK	2.402	3.24	2.109	3 $\pm$ 1	4	2.512	<5	0.77860	3.00	YES
	2.441	2.86	1.932	3 $\pm$ 1	4	2.512	<5	0.78490	3.00	YES
	2.48	2.59	1.816	3 $\pm$ 1	4	2.512	<5	0.79114	3.00	YES
$\pi/4$ -DQPSK	2.402	2.92	1.959	3 $\pm$ 1	4	2.512	<5	0.77860	3.00	YES
	2.441	2.50	1.778	3 $\pm$ 1	4	2.512	<5	0.78490	3.00	YES
	2.48	2.26	1.683	3 $\pm$ 1	4	2.512	<5	0.79114	3.00	YES
8-DPSK	2.402	3.11	2.046	3 $\pm$ 1	4	2.512	<5	0.77860	3.00	YES
	2.441	2.71	1.866	3 $\pm$ 1	4	2.512	<5	0.78490	3.00	YES
	2.48	2.47	1.766	3 $\pm$ 1	4	2.512	<5	0.79114	3.00	YES

**Conclusion:**

For the max result:  $0.79114 \leq 3.0$  for 1-g SAR, No SAR is required.



Signature:

Date: 2019-05-22

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